DF3A6.8FUT1

Preferred Device

Zener ESD Protection Diode

Dual Common Anode Zeners for ESD Protection

These dual monolithic silicon zener diodes are designed for applications requiring transient overvoltage protection capability. They are intended for use in voltage and ESD sensitive equipment such as computers, printers, business machines, communication systems, medical equipment and other applications. Their dual junction common anode design protects two separate lines using only one package. These devices are ideal for situations where board space is at a premium.

Features

- Pb–Free Package is Available
- SC-70 Package Allows Two Separate Unidirectional Configurations
- Low Leakage < 1.0 μA @ 5.0 V
- Breakdown Voltage: 6.4–7.2 V @ 5.0 mA
- ESD Protection Meeting:16 kV Human Body Model 30 kV Contact = IEC61000-4-2
- Peak Power: 24 W @ 1.0 ms (Unidirectional), per Figure 1
- Peak Power: 150 W @ 20 µs (Unidirectional), per Figure 2

Mechanical Characteristics

- Void Free, Transfer–Molded, Thermosetting Plastic Case
- Corrosion Resistant Finish, Easily Solderable
- Package Designed for Optimal Automated Board Assembly
- Small Package Size for High Density Applications

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Steady State Power Dissipation Derate above 25°C (Note 1)	PD	200 1.6	mW mW/°C
Thermal Resistance Junction-to-Ambient	$R_{\theta JA}$	618	°C/W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	– 55 to +150	°C
Peak Power Dissipation @ 1.0 ms (Note 2) @ T _A = 25°C	P _{PK}	20	W
Peak Power Dissipation @ 20 μ s (Note 3) @ T _A = 25°C	P _{PK}	150	W
ESD Discharge MIL STD 883C – Method 3015–6 IEC61000–4–2, Air Discharge IEC61000–4–2, Contact Discharge	V _{PP}	16 30 30	kV

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Mounted on FR–5 Board = $1.0 \times 0.75 \times 0.062$ in.

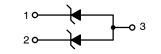
2. Non-repetitive pulse per Figure 1.

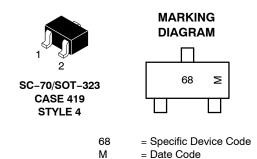
3. Non-repetitive pulse per Figure 2.



ON Semiconductor®

www.onsemi.com





ORDERING INFORMATION

Device	Package	Shipping [†]	
DF3A6.8FUT1	SC-70	3000/Tape & Reel	
DF3A6.8FUT1G	SC–70 (Pb–Free)	3000/Tape & Reel	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

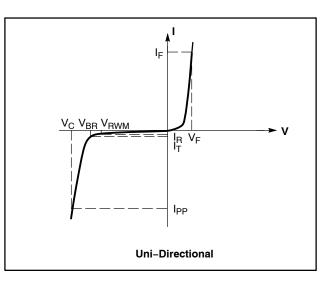
Preferred devices are recommended choices for future use and best overall value.

DF3A6.8FUT1

ELECTRICAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$ UNIDIRECTIONAL (Circuit tied to Pins 1 and 3 or 2 and 3)

Symbol	Parameter		
V _{RWM}	Working Peak Reverse Voltage		
I _R	Maximum Reverse Leakage Current @ V _{RWM}		
V _{BR}	Breakdown Voltage @ I _T		
Ι _Τ	Test Current		
١ _F	Forward Current		
V _F	Forward Voltage @ I _F		
Z _{ZT}	Maximum Zener Impedance @ I _{ZT}		
Z _{ZK}	Maximum Zener Impedance @ I _{ZK}		



ELECTRICAL CHARACTERISTICS (T_A = 25° C unless otherwise noted)

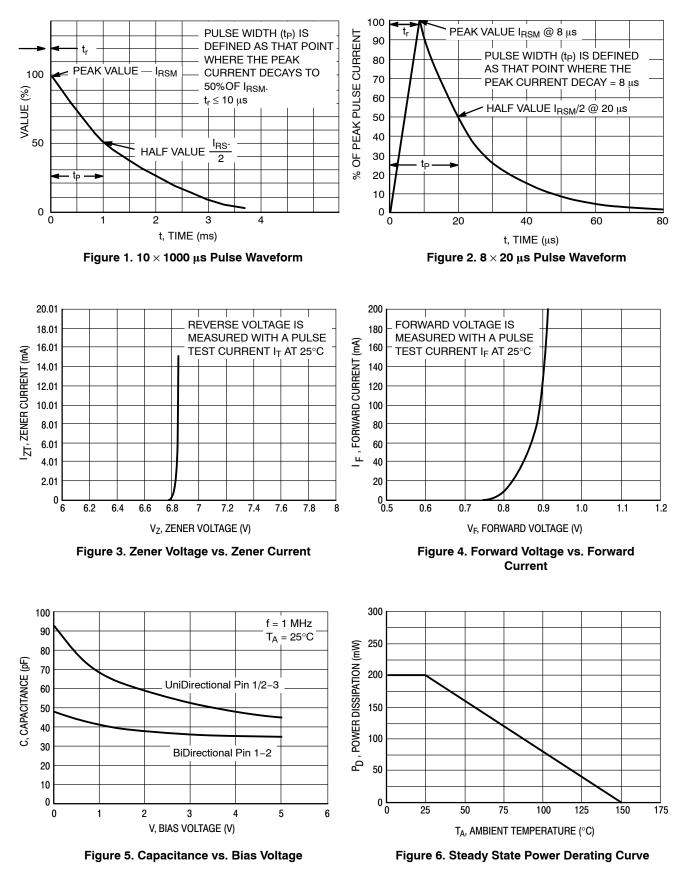
UNIDIRECTIONAL (Circuit tied to Pins 1 and 3 or 2 and 3)

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Forward Voltage	V _F	I _F = 10 mA		0.8	0.9	V
Zener Voltage (Note 4)	VZ	I _{ZT} = 5 mA	6.4	6.8	7.2	V
Operating Resistance (Note 5)	Z _{ZK}	I _{ZK} = 0.5 mA			200	Ω
	Z _{ZT}	I _{ZT} = 5 mA			50	Ω
Reverse Current	I _{R1}	V _{RWM} = 5 V			0.5	μA
Clamping Voltage	V _C	I _{PP} = 2.0 A (Figure 1) I _{PP} = 9.37 A (Figure 2)			9.6	V
		ipp = 0.01 / (i igaio _)			16	V
ESD Protection Human Body Model (HBM) Contact – IEC61000–4–2 Air Discharge					16 30 30	kV

V_Z measured at pulse test current I_{ZT} at an ambient temperature of 25°C.
Z_{ZT} and Z_{ZK} is measured by dividing the AC voltage drop across the device by the AC current supplied. AC frequency = 1.0 kHz.

DF3A6.8FUT1

TYPICAL CHARACTERISTICS



MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

onsemi

